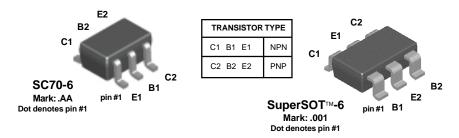


FFB2227A

FMB2227A



NPN & PNP General Purpose Amplifier

This complementary device is for use as a medium power amplifier and switch requiring collector currents up to 500 mA. Sourced from Process 19 and 63. See FFB2222A (NPN) and FFB2907A (PNP) for characteristics.

Absolute Maximum Ratings* $T_{\Delta} = 25$ °C unless otherwise noted

Symbol	Parameter	Value	Units
V _{CEO}	Collector-Emitter Voltage	30	V
V _{CBO}	Collector-Base Voltage	60	V
V _{EBO}	Emitter-Base Voltage	5.0	V
Ic	Collector Current - Continuous	500	mA
T _J , T _{stg}	Operating and Storage Junction Temperature Range	-55 to +150	°C

^{*}These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

- 1) These ratings are based on a maximum junction temperature of 150 degrees C.
- 2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

 3) All voltages (V) and currents (A) are negative polarity for PNP transistors.

Thermal Characteristics T_A = 25°C unless otherwise noted

Symbol	Characteristic	M	ax	Units
		FFB2227A	FMB2227A	
P_D	Total Device Dissipation Derate above 25°C	300 2.4	700 5.6	mW mW/°C
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	415	180	°C/W

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NPN & PNP General Purpose Amplifier (continued)

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T_A = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
			•			
OFF CHAP	RACTERISTICS					
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage*	$I_C = 10 \text{ mA}, I_B = 0$	30			V
V _{(BR)CBO}	Collector-Base Breakdown Voltage	$I_C = 10 \mu A, I_E = 0$	60			V
V _{(BR)EBO}	Emitter-Base Breakdown Voltage	$I_E = 10 \mu A, I_C = 0$	5.0			V
Ісво	Collector Cutoff Current	$V_{CB} = 50 \text{ V}, I_{E} = 0$			30	nA
I _{EBO}	Emitter Cutoff Current	V _{EB} = 3.0 V, I _C = 0			30	nA
ON CHAR	ACTERISTICS					
h _{FE}	DC Current Gain	$I_C = 1.0 \text{ mA}, V_{CE} = 10 \text{ V}$	50			
		$I_C = 10 \text{ mA}, V_{CE} = 10 \text{ V}$ $I_C = 150 \text{ mA}, V_{CE} = 10 \text{ V}^*$	75 100			
		$I_C = 150 \text{ mA}, V_{CE} = 10 \text{ V}$ $I_C = 300 \text{mA}, V_{CE} = 10 \text{ V}^*$	30			
V _{CE(sat)}	Collector-Emitter Saturation Voltage*	I _C = 150 mA, I _B = 15 mA	- 55		0.4	V
		1 000 4 1 00 4				١ ، ،
		$I_C = 300 \text{ mA}, I_B = 30 \text{ mA}$			1.4	V
V _{BE(sat)}	Base-Emitter Saturation Voltage*	$I_C = 300 \text{ mA}, I_B = 30 \text{ mA}$ $I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$			1.4	V
V _{BE(sat)}	· · · · · · · · · · · · · · · · · · ·					V
V _{BE(sat)}	Base-Emitter Saturation Voltage* GNAL CHARACTERISTICS Current Gain - Bandwidth Product	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$ $I_C = 50 \text{ mA}, V_{CE} = 20 \text{ V},$		250		V
V _{BE(sat)} SMALL SI	GNAL CHARACTERISTICS Current Gain - Bandwidth Product	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$ $I_C = 50 \text{ mA}, V_{CE} = 20 \text{ V},$ $f = 100 \text{ MHz}$				V MHz
$V_{BE(sat)}$ $\begin{array}{c} SMALL\ SI \\ f_T \\ C_{obo} \end{array}$	GNAL CHARACTERISTICS Current Gain - Bandwidth Product Output Capacitance	$I_C = 150$ mA, $I_B = 15$ mA $I_C = 50$ mA, $V_{CE} = 20$ V, f = 100 MHz $V_{CB} = 10$ V, $I_E = 0$, $f = 100$ kHz		4.0		V MHz pF
$V_{BE(sat)}$ $\begin{array}{c} SMALL\ SI \\ f_T \\ C_{obo} \\ C_{ibo} \end{array}$	GNAL CHARACTERISTICS Current Gain - Bandwidth Product Output Capacitance Input Capacitance	$\begin{split} I_C &= 150 \text{ mA}, \ I_B = 15 \text{ mA} \\ \\ I_C &= 50 \text{ mA}, \ V_{CE} = 20 \text{ V}, \\ f &= 100 \text{ MHz} \\ \\ V_{CB} &= 10 \text{ V}, \ I_E = 0, \ f = 100 \text{ kHz} \\ \\ V_{EB} &= 2.0 \text{ V}, \ I_C = 0, \ f = 100 \text{ kHz} \end{split}$		4.0		MHz pF pF
V _{BE(sat)}	GNAL CHARACTERISTICS Current Gain - Bandwidth Product Output Capacitance	$I_C = 150$ mA, $I_B = 15$ mA $I_C = 50$ mA, $V_{CE} = 20$ V, f = 100 MHz $V_{CB} = 10$ V, $I_E = 0$, $f = 100$ kHz		4.0		V MHz pF
$V_{BE(sat)}$ $\begin{array}{c} SMALL\ SI \\ f_T \\ C_{obo} \\ C_{ibo} \end{array}$	GNAL CHARACTERISTICS Current Gain - Bandwidth Product Output Capacitance Input Capacitance	$\begin{split} I_C &= 150 \text{ mA}, \ I_B = 15 \text{ mA} \\ \\ I_C &= 50 \text{ mA}, \ V_{CE} = 20 \text{ V}, \\ f &= 100 \text{ MHz} \\ \\ V_{CB} &= 10 \text{ V}, \ I_E = 0, \ f = 100 \text{ kHz} \\ \\ V_{EB} &= 2.0 \text{ V}, \ I_C = 0, \ f = 100 \text{ kHz} \\ \\ I_C &= 100 \text{ \muA}, \ V_{CE} = 10 \text{ V}, \end{split}$		4.0		MHz pF pF
V _{BE(sat)} SMALL SI f _T C _{obo} Cibo NF	GNAL CHARACTERISTICS Current Gain - Bandwidth Product Output Capacitance Input Capacitance	$\begin{split} I_C &= 150 \text{ mA}, \ I_B = 15 \text{ mA} \\ \\ I_C &= 50 \text{ mA}, \ V_{CE} = 20 \text{ V}, \\ f &= 100 \text{ MHz} \\ \\ V_{CB} &= 10 \text{ V}, \ I_E = 0, \ f = 100 \text{ kHz} \\ \\ V_{EB} &= 2.0 \text{ V}, \ I_C = 0, \ f = 100 \text{ kHz} \\ \\ I_C &= 100 \text{ \muA}, \ V_{CE} = 10 \text{ V}, \end{split}$		4.0		MHz pF pF
V _{BE(sat)} SMALL SI f _T C _{obo} C _{ibo} NF SWITCHII	GNAL CHARACTERISTICS Current Gain - Bandwidth Product Output Capacitance Input Capacitance Noise Figure	$\begin{split} I_C &= 150 \text{ mA}, \ I_B = 15 \text{ mA} \\ \\ I_C &= 50 \text{ mA}, \ V_{CE} = 20 \text{ V}, \\ f &= 100 \text{ MHz} \\ \\ V_{CB} &= 10 \text{ V}, \ I_E = 0, \ f = 100 \text{ kHz} \\ \\ V_{EB} &= 2.0 \text{ V}, \ I_C = 0, \ f = 100 \text{ kHz} \\ \\ I_C &= 100 \text{ \muA}, \ V_{CE} = 10 \text{ V}, \end{split}$		4.0		MHz pF pF
V _{BE(sat)} SMALL SI f _T C _{obo} Cibo NF	GNAL CHARACTERISTICS Current Gain - Bandwidth Product Output Capacitance Input Capacitance Noise Figure NG CHARACTERISTICS	$\begin{split} I_C &= 150 \text{ mA}, \ I_B = 15 \text{ mA} \\ \\ I_C &= 50 \text{ mA}, \ V_{CE} = 20 \text{ V}, \\ f &= 100 \text{ MHz} \\ \\ V_{CB} &= 10 \text{ V}, \ I_E = 0, \ f = 100 \text{ kHz} \\ \\ V_{EB} &= 2.0 \text{ V}, \ I_C = 0, \ f = 100 \text{ kHz} \\ \\ I_C &= 100 \mu\text{A}, \ V_{CE} = 10 \text{ V}, \\ R_S &= 1.0 k\Omega, \ f = 1.0 \text{ kHz} \end{split}$		4.0 12 2.0		V MHz pF pF dB
V _{BE(sat)} SMALL SI f _T C _{obo} C _{ibo} NF SWITCHII t _{on}	GNAL CHARACTERISTICS Current Gain - Bandwidth Product Output Capacitance Input Capacitance Noise Figure NG CHARACTERISTICS Turn-on Time	$\begin{split} I_C &= 150 \text{ mA}, \ I_B = 15 \text{ mA} \\ \\ I_C &= 50 \text{ mA}, \ V_{CE} = 20 \text{ V}, \\ f &= 100 \text{ MHz} \\ \\ V_{CB} &= 10 \text{ V}, \ I_E = 0, \ f = 100 \text{ kHz} \\ \\ V_{EB} &= 2.0 \text{ V}, \ I_C = 0, \ f = 100 \text{ kHz} \\ \\ I_C &= 100 \mu\text{A}, \ V_{CE} = 10 \text{ V}, \\ \\ R_S &= 1.0 k\Omega, \ f = 1.0 \text{ kHz} \\ \\ \\ V_{CC} &= 30 \text{ V}, \ I_C = 150 \text{ mA}, \end{split}$		4.0 12 2.0		V MHz pF pF dB
SMALL SI fT Cobo Cibo NF SWITCHII ton td	GNAL CHARACTERISTICS Current Gain - Bandwidth Product Output Capacitance Input Capacitance Noise Figure NG CHARACTERISTICS Turn-on Time Delay Time	$\begin{split} I_C &= 150 \text{ mA}, \ I_B = 15 \text{ mA} \\ \\ I_C &= 50 \text{ mA}, \ V_{CE} = 20 \text{ V}, \\ f &= 100 \text{ MHz} \\ \\ V_{CB} &= 10 \text{ V}, \ I_E = 0, \ f = 100 \text{ kHz} \\ \\ V_{EB} &= 2.0 \text{ V}, \ I_C = 0, \ f = 100 \text{ kHz} \\ \\ I_C &= 100 \mu\text{A}, \ V_{CE} = 10 \text{ V}, \\ \\ R_S &= 1.0 k\Omega, \ f = 1.0 \text{ kHz} \\ \\ \\ V_{CC} &= 30 \text{ V}, \ I_C = 150 \text{ mA}, \end{split}$		4.0 12 2.0 30 8.0		V MHz pF pF dB ns ns
V _{BE(sat)} SMALL SI f _T C _{obo} C _{ibo} NF SWITCHII	GNAL CHARACTERISTICS Current Gain - Bandwidth Product Output Capacitance Input Capacitance Noise Figure NG CHARACTERISTICS Turn-on Time Delay Time Rise Time	$\begin{split} &I_C = 150 \text{ mA}, \ I_B = 15 \text{ mA} \\ &I_C = 50 \text{ mA}, \ V_{CE} = 20 \text{ V}, \\ &f = 100 \text{ MHz} \\ &V_{CB} = 10 \text{ V}, \ I_E = 0, \ f = 100 \text{ kHz} \\ &V_{EB} = 2.0 \text{ V}, \ I_C = 0, \ f = 100 \text{ kHz} \\ &I_C = 100 \ \mu\text{A}, \ V_{CE} = 10 \text{ V}, \\ &R_S = 1.0 \ k\Omega, \ f = 1.0 \text{ kHz} \\ \end{split}$		30 8.0 20		V MHz pF dB ns ns ns

^{*}Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%

NOTE: All voltages (V) and currents (A) are negative polarity for PNP transistors.

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